

UG10111

MCX Nx4x TSI User Guide

Rev. 1 — 7 May 2024

User guide

Document information

Information	Content
Keywords	MCX, MCX Nx4x, TSI, touch.
Abstract	The Touch Sensing Interface (TSI) of the MCX Nx4x series is the upgraded IP with new features to implement the baseline/threshold autotuning.



1 Introduction

The MCX N series of the Industrial and IoT (IIoT) MCU feature dual Arm Cortex-M33 cores operates up to 150 MHz. The MCX N series are high-performance, low-power microcontrollers with intelligent peripherals and accelerators providing multitasking capabilities and performance efficiency. The Touch Sensing Interface (TSI) of the MCX Nx4x series is the upgraded IP with new features to implement the baseline/threshold autotuning.

2 MCX Nx4x TSI overview

TSI provides touch-sensing detection on capacitive touch sensors. The external capacitive touch sensor is typically formed on PCB and the sensor electrodes are connected to the TSI input channels through the I/O pins in the device.

2.1 MCX Nx4x TSI block diagram

MCX Nx4x has one TSI module and supports 2 kinds of touch sensing methods, the self-capacitance (also called self-cap) mode and the mutual-capacitance (also called mutual-cap) mode.

The block diagram of MCX Nx4x TSI I shown in [Figure 1](#):

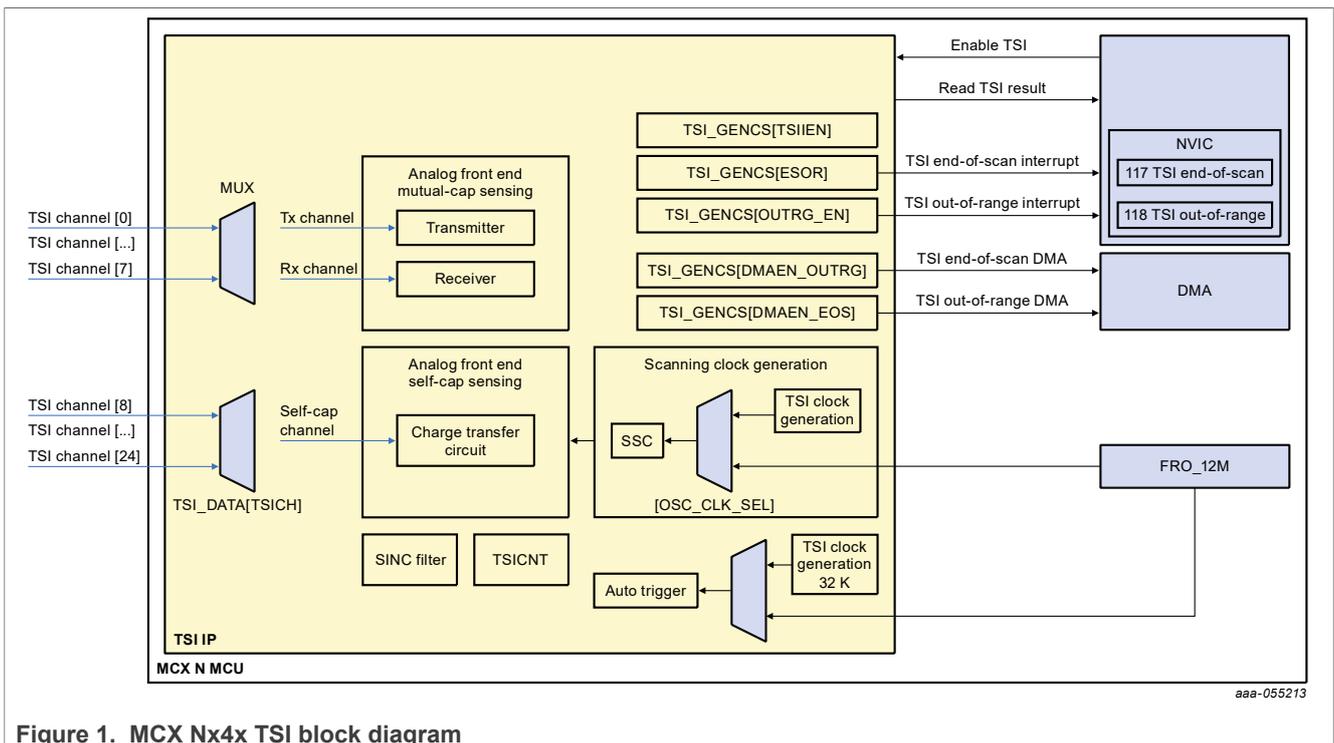


Figure 1. MCX Nx4x TSI block diagram

The TSI module of MCX Nx4x has 25 touch channels. 4 of these channels can be used as shield channels to enhance the drive strength of touch channels.

The 4 shield channels are used to enhance the liquid tolerance and improve the driving ability. The enhanced driving ability also enables users to design a larger touchpad on the hardware board.

The TSI module of MCX Nx4x has up to 25 touch channels for self-cap mode and up to 8 x 17 touch channels for mutual-cap mode. Both mentioned methods can be combined on a single PCB, but the TSI channel is more flexible for Mutual-cap mode. The TSI[0:7] are TSI Tx pins and TSI[8:25] are TSI Rx pins in Mutual-cap mode.

In self-capacitive mode, developers can use 25 self-cap channels to design 25 touch electrodes.

In mutual-capacitive mode, design options expand to up to 136 (8 x 17) touch electrodes.

Several use cases such as a multiburner induction cooker with touch controls, touch keyboards, touchscreen, require a lot of touch key design. The MCX Nx4x TSI can support up to 136 touch electrodes when mutual-cap channels are used.

The MCX Nx4x TSI can expand more touch electrodes to meet the requirements of multiple touch electrodes. Some new features have been added to make the IP easier to be used in low-power mode. TSI has advanced EMC robustness, which makes it suitable for use in industrial, home appliance, and consumer electronics applications.

2.2 MCX Nx4x parts supported TSI

[Table 1](#) shows the number of TSI channels corresponding to different parts of the MCX Nx4x series. All these parts support one TSI module that has 25 channels.

Table 1. MCX Nx4x parts supporting TSI module

Parts	Frequency [Max] (MHz)	Flash (MB)	SRAM (kB)	TSI [Number, channels]	GPIOs	Package type
MCXN546VDFT	150	1	352	1 x 25	124	VFBGA184
MCXN546VNLT	150	1	352	1 x 25	74	HLQFP100
MCXN547VDFT	150	2	512	1 x 25	124	VFBGA184
MCXN547VNLT	150	2	512	1 x 25	74	HLQFP100
MCXN946VDFT	150	1	352	1 x 25	124	VFBGA184
MCXN946VNLT	150	1	352	1 x 25	78	HLQFP100
MCXN947VDFT	150	2	512	1 x 25	124	VFBGA184
MCXN947VNLT	150	2	512	1 x 25	78	HLQFP100

2.3 MCX Nx4x TSI channel assignment on different packages

Table 2. TSI channel assignment for MCX Nx4x VFBGA and LQFP packages

184BGA ALL	184BGA ALL pin name	100HLQFP N94X	100HLQFP N94X pin name	100HLQFP N54X	100HLQFP N54X pin name	TSI channel
A1	P1_8	1	P1_8	1	P1_8	TSI0_CH17/ADC1_A8
B1	P1_9	2	P1_9	2	P1_9	TSI0_CH18/ADC1_A9
C3	P1_10	3	P1_10	3	P1_10	TSI0_CH19/ADC1_A10
D3	P1_11	4	P1_11	4	P1_11	TSI0_CH20/ADC1_A11
D2	P1_12	5	P1_12	5	P1_12	TSI0_CH21/ADC1_A12
D1	P1_13	6	P1_13	6	P1_13	TSI0_CH22/ADC1_A13
D4	P1_14	7	P1_14	7	P1_14	TSI0_CH23/ADC1_A14
E4	P1_15	8	P1_15	8	P1_15	TSI0_CH24/ADC1_A15
B14	P0_4	80	P0_4	80	P0_4	TSI0_CH8
A14	P0_5	81	P0_5	81	P0_5	TSI0_CH9
C14	P0_6	82	P0_6	82	P0_6	TSI0_CH10
B10	P0_16	84	P0_16	84	P0_16	TSI0_CH11/ADC0_A8

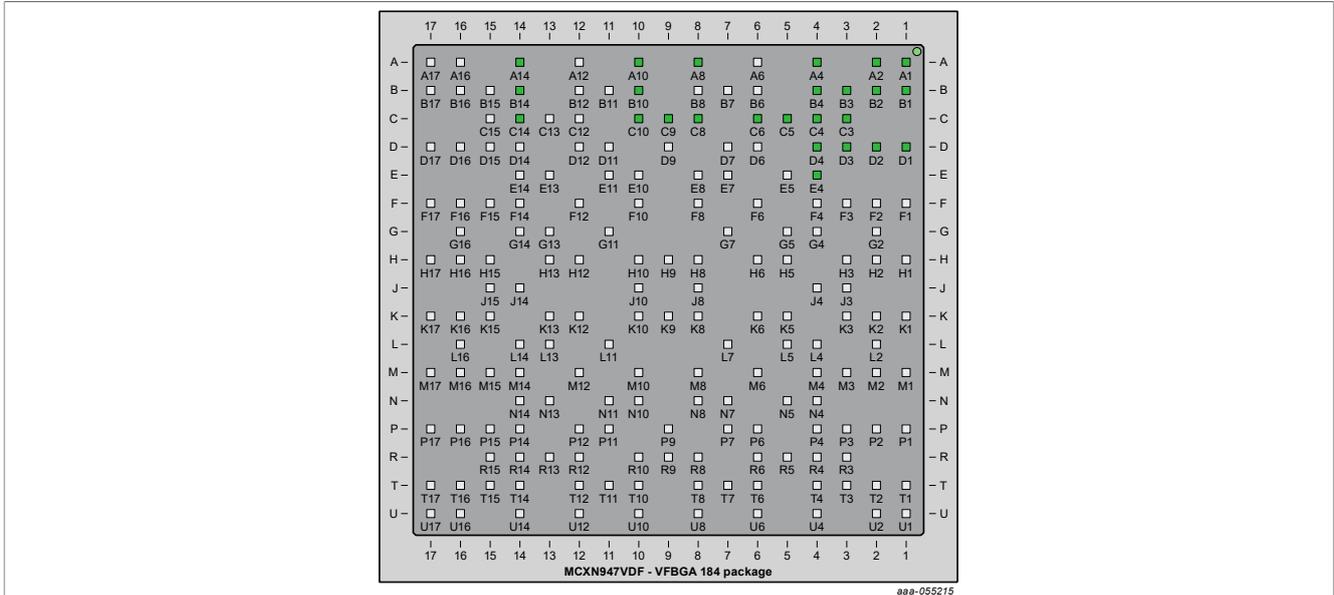


Figure 3. TSI channel assignment of MCX Nx4x 100LQFP and 164VFBGA

3 MCX Nx4x TSI features

This section gives the details of MCX Nx4x TSI features.

3.1 TSI comparison between MCX Nx4x TSI and Kinetis TSI

MCX Nx4x of TSI and TSI on the NXP Kinetis E series TSI are designed on different technology platforms. Therefore, from the basic features of TSI to the registers of TSI, there are differences between MCX Nx4x TSI and TSI of the Kinetis E series. Only the differences are listed in this document. To check the TSI registers, use the reference manual.

This chapter describes the features of MCX Nx4x TSI by comparing it to the TSI of the Kinetis E series.

As shown in [Table 3](#), MCX Nx4x TSI is not affected by the VDD noise. It has more function clock choices. If the function clock is configured from the chip system clock, the TSI power consumption can be decreased. Even though the MCX Nx4x TSI has only one TSI module, it supports designing more hardware touch keys on a hardware board when using mutual-cap mode.

Table 3. The difference between MCX Nx4x TSI and Kinetis E TSI (KE17Z256)

	MCX Nx4x series	Kinetis E series
Operating voltage	1.71 V – 3.6 V	2.7 V – 5.5 V
VDD noise impact	No	Yes
Function clock source	<ul style="list-style-type: none"> • TSI IP internal generated • Chip system clock 	TSI IP internal generated
Function clock range	30 KHz - 10 MHz	37 KHz - 10 MHz
TSI channels	Up to 25 channels (TSI0)	Up to 50 channels (TSI0, TSI1)
Shield channels	4 shield channels: CH0, CH6, CH12, CH18	3 shield channels for each TSI: CH4, CH12, CH21
Touch mode	Self-cap mode: TSI[0:24]	Self-cap mode: TSI[0:24]

Table 3. The difference between MCX Nx4x TSI and Kinetis E TSI (KE17Z256)...continued

	MCX Nx4x series	Kinetis E series
	Mutual-cap mode: Tx[0:7], Rx[8:24]	Mutual-cap mode: Tx[0:5], Rx[6:12]
Touch electrodes	self-cap electrodes: up to 25 mutual-cap electrodes: up to 136 (8x17)	self-cap electrodes: up to 50 (25+25) mutual-cap electrodes: up to 72 (6x6+6x6)
Products	MCX N9x and MCX N5x	KE17Z256

The features supported both by MCX Nx4x TSI and Kinetis TSI are shown in [Table 4](#).

Table 4. The features supported both by MCX Nx4x TSI and Kinetis TSI

	MCX Nx4x series	Kinetis E series
Two kinds of Sensing mode	Self-cap mode: Basic self-cap mode Sensitivity boost mode Noise cancellation mode Mutual-cap mode: Basic mutual-cap mode Sensitivity boost enable	
Interrupt support	End of scan interrupt Out of range interrupt	
Trigger source support	1. Software trigger by writing the GENCS [SWTS] bit 2. Hardware trigger through INPUTMUX 3. Automatic trigger by AUTO_TRIG [TRIG_EN]	1. Software trigger by writing the GENCS [SWTS] bit 2. Hardware trigger through INPUTMUX
Low-power support	Deep Sleep: fully function when GENCS [STPE] is set to 1 Power Down: If the WAKE domain is active, TSI can operate as in "Deep Sleep" mode. Deep Power Down, VBAT: not available	STOP mode, VLPS mode: fully functioning when GENCS [STPE] is set to 1.
Low-power wake-up	Each TSI channel can wake up the MCU from low-power mode.	
DMA support	The out of range event or end of scan event can trigger the DMA transfer.	
Hardware noise filter	SSC reduces the frequency noise and promotes the signal-to-noise ratio (PRBS mode, up-down counter mode).	

3.2 MCX Nx4x TSI new features

Some new features are added to MCX Nx4x TSI. The most significant are listed in the table below. MCX Nx4x TSI provides a richer range of features for users. Like the functions of Baseline auto trace, Threshold auto trace, Debounce, these features can realize some hardware calculations. It saves software development resources.

Table 5. MCX Nx4x TSI new features

	MCX Nx4x series
1	Proximity channels merge function
2	Baseline auto trace function
3	Threshold auto trace function

Table 5. MCX Nx4x TSI new features...continued

4	Debounce function
5	Automatic trigger function
6	Clock from chip system clock
7	Test finger function

3.3 MCX Nx4x TSI function description

Here is the description of these newly added features:

1. The proximity channels merge function

The proximity function is used to merge multiple TSI channels for scanning. Configure `TSI0_GENCS[S_PROX_EN]` to 1 to enable the proximity mode, the value in `TSI0_CONFIG[TSICH]` is invalid, it is not used to select channel in proximity mode. The 25-bit register `TSI0_CHMERGE[CHANNEL_ENABLE]` is configured to select multiple channels, the 25-bit controls the selection of 25 TSI channels. It can select up to 25 channels, by configuring the 25 bits to 1 (1_1111_1111_1111_1111_1111b). When a trigger occurs, the multiple channels selected by `TSI0_CHMERGE[CHANNEL_ENABLE]` are scanned together, and generate one set of the TSI scan value. The scan value can be read from register `TSI0_DATA[TSICNT]`. The proximity merge function theoretically integrates the capacitance of the multiple channels and then starts scanning, which is only valid in self-cap mode. The more touch channels merged can get a shorter scanning time, the smaller is the scanning value, and the poorer is the sensitivity. Therefore, when touch detect, more touch capacitance is needed to get the higher sensitivity. This function is suitable for the large area touch detect and large area proximity detect.

2. Baseline auto trace function

The TSI of MCX Nx4x provides the register to set the baseline of TSI and the baseline trace function. After the TSI channel software calibration is complete, fill an initialize baseline value in the `TSI0_BASELINE[BASELINE]` register. The initial baseline of the touch channel in the `TSI0_BASELINE[BASELINE]` register is written in the software by the user. The setting of the baseline is valid only for one channel. The baseline trace function can adjust the baseline in the `TSI0_BASELINE[BASELINE]` register to make it close to the TSI current sample value. The baseline trace enable function is enabled by the `TSI0_BASELINE[BASE_TRACE_EN]` bit, and the autotrace ratio is set in the register `TSI0_BASELINE[BASE_TRACE_DEBOUNCE]`. The baseline value is increased or decreased automatically, the change value for each increase/decrease is $BASELINE * BASE_TRACE_DEBOUNCE$. The baseline trace function is only enabled in low-power mode and the setting is valid only for one channel. When the touch channel is changed, the baseline-related registers must be reconfigured.

3. Threshold auto trace function

The threshold can be calculated by the IP internal hardware if the threshold trace is enabled by configuring the `TSI0_BASELINE[THRESHOLD_TRACE_EN]` bit to 1. The calculated threshold value is loaded to threshold register `TSI0_TSHD`. To get the desired threshold value, select the threshold ratio in `TSI0_BASELINE[THRESHOLD_RATIO]`. The threshold of the touch channel is calculated according to the below formula in the IP internal.

$$\text{Threshold_H: } TSI0_TSHD[THRESH] = [BASELINE + BASELINE \gg (THRESHOLD_RATIO+1)]$$

$$\text{Threshold_L: } TSI0_TSHD[THRESL] = [BASELINE - BASELINE \gg (THRESHOLD_RATIO+1)]$$

`BASELINE` is the value in `TSI0_BASELINE[BASELINE]`.

4. Debounce function

MCX Nx4x TSI provides the hardware debounce function, the `TSI_GENCS[DEBOUNCE]` can be used to configure the number of out-of-range events that can generate an interrupt. Only the out-of-range interrupt event mode supports the debounce function and the end-of-scan interrupt event does not support it.

- Automatic trigger function. There are three trigger sources of TSI, including the software trigger by writing the `TSI0_GENCS[SWTS]` bit, the hardware trigger through INPUTMUX, and the automatic trigger by `TSI0_AUTO_TRIG[TRIG_EN]`. Figure 4 shows the automatically trigger-generated progress.

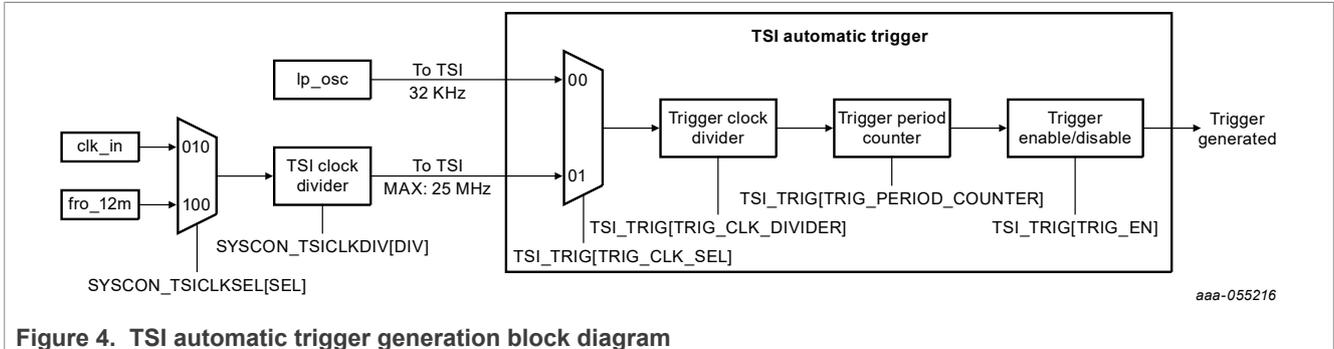


Figure 4. TSI automatic trigger generation block diagram

The automatic trigger function is a new feature in MCX Nx4x TSI. This feature is enabled by setting `TSI0_AUTO_TRIG[TRIG_EN]` to 1. Once the automatic trigger is enabled, the software trigger and hardware trigger configuration in `TSI0_GENCS[SWTS]` is invalid. The time period between each trigger can be calculated by the below formula:

Timer period between each trigger = trigger clock / trigger clock divider * trigger clock counter.

Trigger clock: configure `TSI0_AUTO_TRIG[TRIG_CLK_SEL]` to select the automatic trigger clock source.

Trigger clock divider: configure `TSI0_AUTO_TRIG[TRIG_CLK_DIVIDER]` to select the trigger clock divider.

Trigger clock counter: configure `TSI0_AUTO_TRIG[TRIG_PERIOD_COUNTER]` to configure the trigger clock counter value.

For the clock of the automatic trigger clock source, one is the `lp_osc` 32k clock, another is the `FRO_12Mhz` clock or the `clk_in` clock can be selected by `TSICLKSEL[SEL]`, and divided by `TSICLKDIV[DIV]`.

- Clock from chip system clock

Usually, Kinetis E series TSI provides an internal reference clock to generate the TSI functional clock. For the TSI of MCX Nx4x, the operating clock cannot only be from the IP internal, but it can be from the chip system clock. MCX Nx4x TSI has two function clock source choices (by configuring `TSICLKSEL[SEL]`). As shown in Figure 5, one from the chip system clock can decrease the TSI operate power consumption, another is generated from the TSI internal oscillator. It can decrease the jitter of the TSI operate clock.

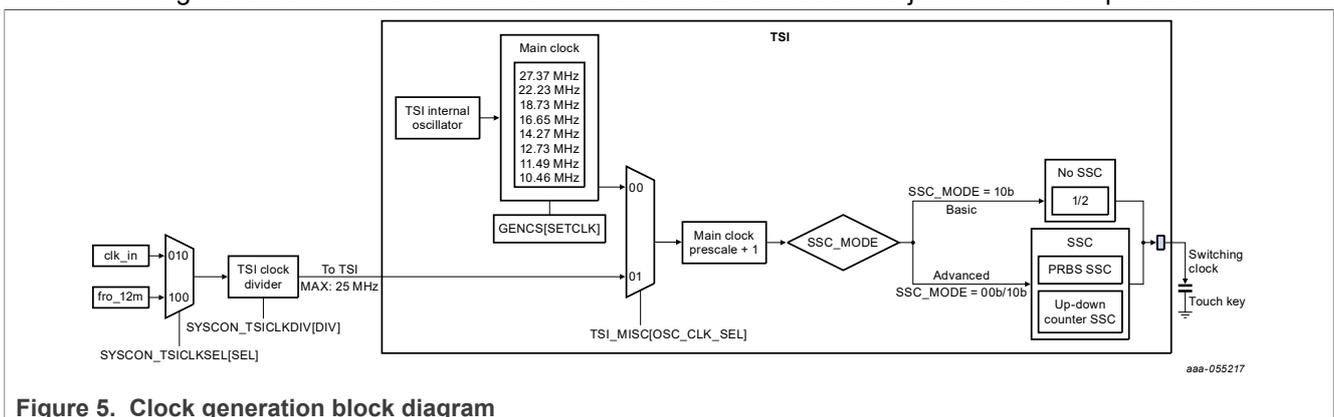


Figure 5. Clock generation block diagram

`FRO_12` MHz clock or the `clk_in` clock is the TSI function clock source, it can be selected by `TSICLKSEL[SEL]` and divided by `TSICLKDIV[DIV]`.

- Test finger function

MCX Nx4x TSI provides the test finger function that can simulate a finger touch without a real finger touch on the hardware board by configuring the related register. This function is useful during the code debug and hardware board test.

The strength of the TSI test finger can be configured by `TSIO_MISC[TEST_FINGER]`, the user can change the touch strength through it. There are 8 options for the finger capacitance: 148pF, 296pF, 444pF, 592pF, 740pF, 888pF, 1036pF, 1184pF. The test finger function is enabled by configuring `TSIO_MISC[TEST_FINGER_EN]` to 1.

The user can use this function to calculate the hardware touchpad capacitance, the TSI parameter debug and do the software safety /failure tests (FMEA). In the software code, configure the finger capacitance first and then enable the test finger function.

3.4 Example use case of MCX Nx4x TSI new function

MCX Nx4x TSI has a feature for the low-power use case:

- Use the chip system clock to save the IP power consumption.
- Use automatic trigger function, proximity channels merge function, baseline auto trace function, threshold auto trace function, debounce function to do an easy low-power wake-up use case.

4 MCX Nx4x TSI hardware and software support

NXP has four kinds of hardware boards to support the MCX Nx4x TSI evaluation. The X-MCX-N9XX-TSI board is the internal evaluation board, contract FAE/Marketing to request it. The other three boards are NXP official release boards and can be found on in the [NXP](#) web where the user can download the official supported software SDK and touch library.

4.1 MCX Nx4x series TSI evaluation board

NXP provides evaluation boards to help users to evaluate the TSI function. The following is the detailed board information.

4.1.1 X-MCX-N9XX-TSI board

The X-MCX-N9XX-TSI board is a touch sensing reference design including multiple touch patterns based on the NXP high-performance MCX Nx4x MCU that has one TSI module and supports up to 25 touch channels demonstrated on the board. The board can be used to evaluate the TSI function for the MCX N9x and N5x series MCU. This product has passed the IEC61000-4-6 3V certification.



Figure 6. X-MCX-N9XX-TSI, MCX N5/N9 dedicated TSI evaluation board

4.1.2 MCX-N5XX-EVK

[MCX-N5XX-EVK](#) provides the touch slider on the board, and it is compatible with the FRDM-TOUCH board. NXP provides a touch library to realize the functions of keys, slider, and rotary touches.

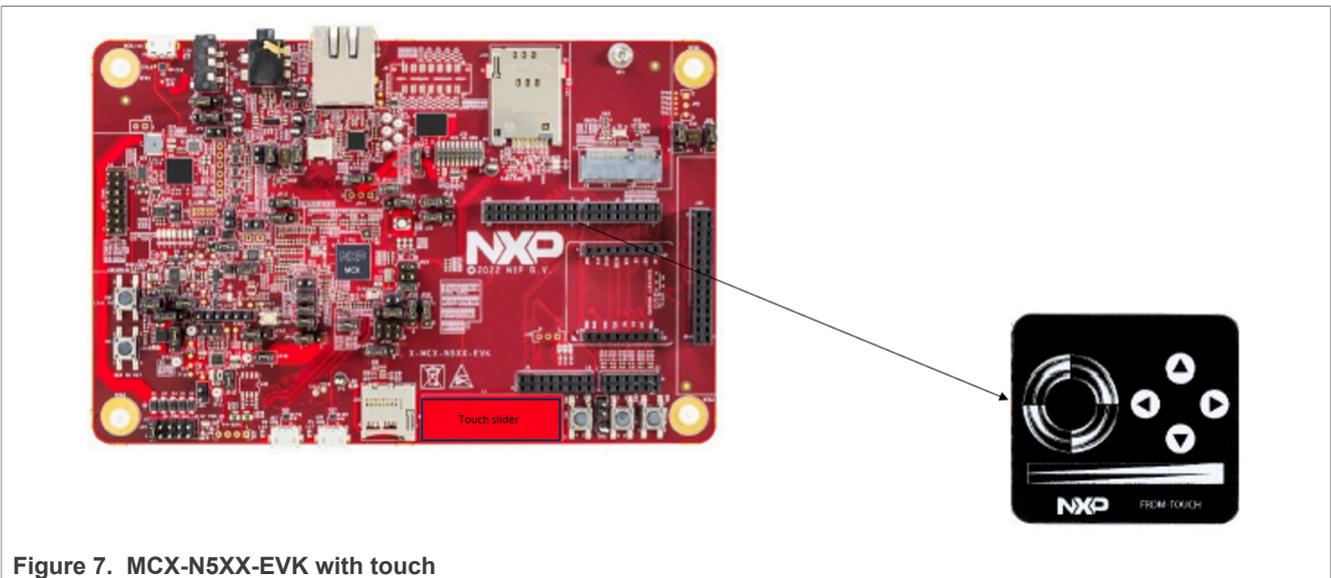


Figure 7. MCX-N5XX-EVK with touch

4.1.3 MCX-N9XX-EVK

[MCX-N9XX-EVK](#) provides the touch slider on the board, and it is compatible with the FRDM-TOUCH board. NXP provides a touch library to realize the functions of keys, slider, and rotary touches.

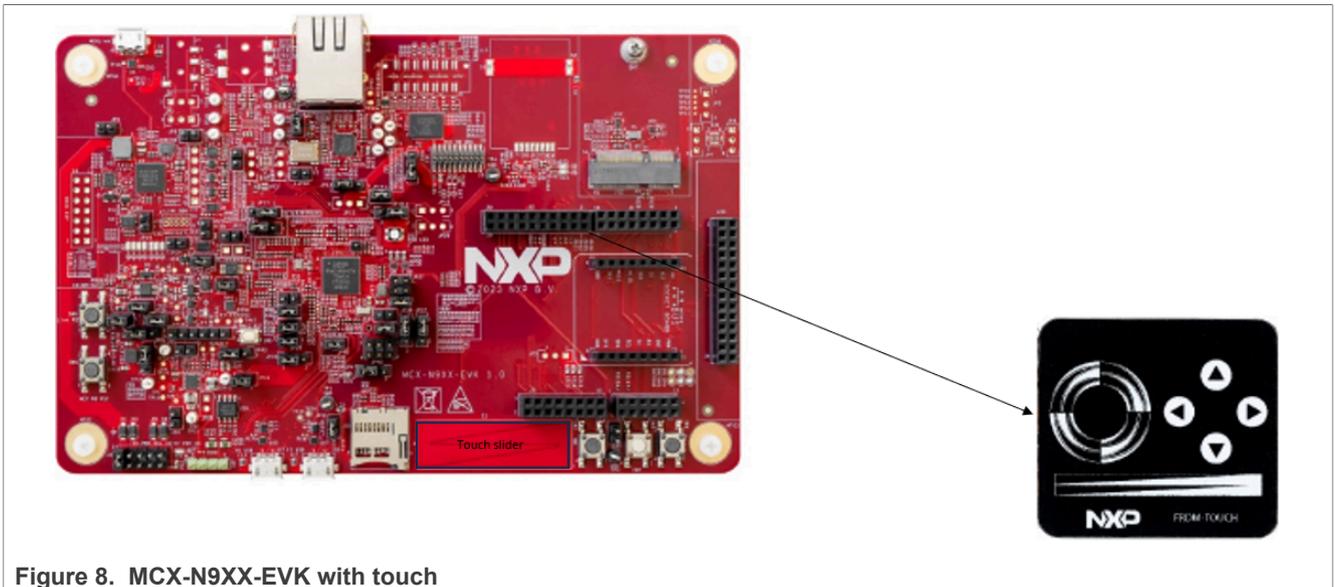


Figure 8. MCX-N9XX-EVK with touch

4.1.4 FRDM-MCXN947

[FRDM-MCXN947](#) provides a one-touch key on the board and it is compatible with the FRDM-TOUCH board. NXP provides a touch library to realize the functions of keys, slider, and rotary touches.

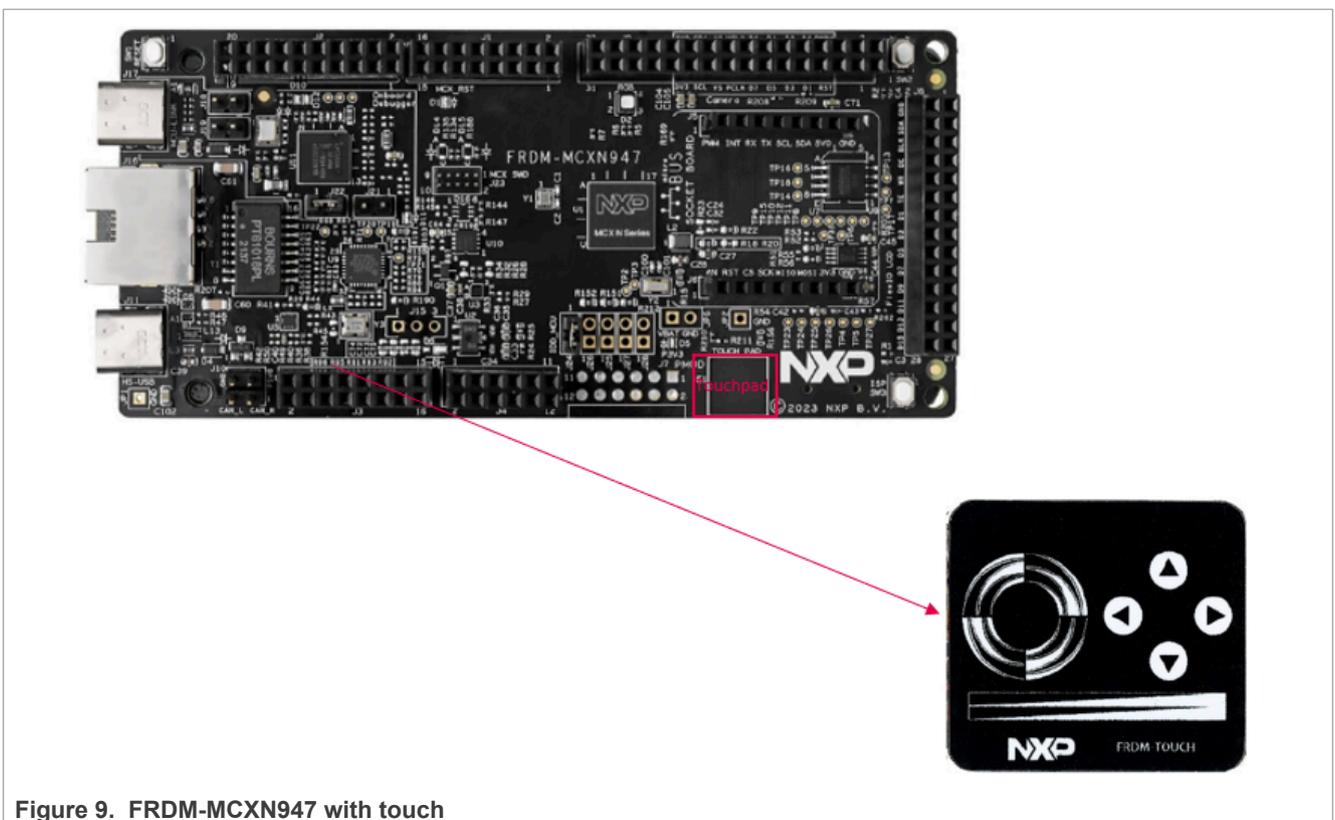


Figure 9. FRDM-MCXN947 with touch

4.2 NXP touch library support for MCX Nx4x TSI

NXP offers a touch software library free of charge. It provides all the software required to detect touches and to implement more advanced controllers like sliders or keypads. TSI background algorithms are available for touch keypad and analog decoders, sensitivity auto calibration, low-power, proximity, water tolerance. The SW is distributed in source code form in “object C language code structure”. And a touch tuner tool based on FreeMASTER is provided for TSI configuration and tune.

4.2.1 SDK build and touch library download

The user can build SDK of MCX hardware boards from <https://mcuxpresso.nxp.com/en/welcome>, add the touch library to the SDK and download the package. The process is shown on [Figure 10](#), [Figure 11](#), and [Figure 12](#).

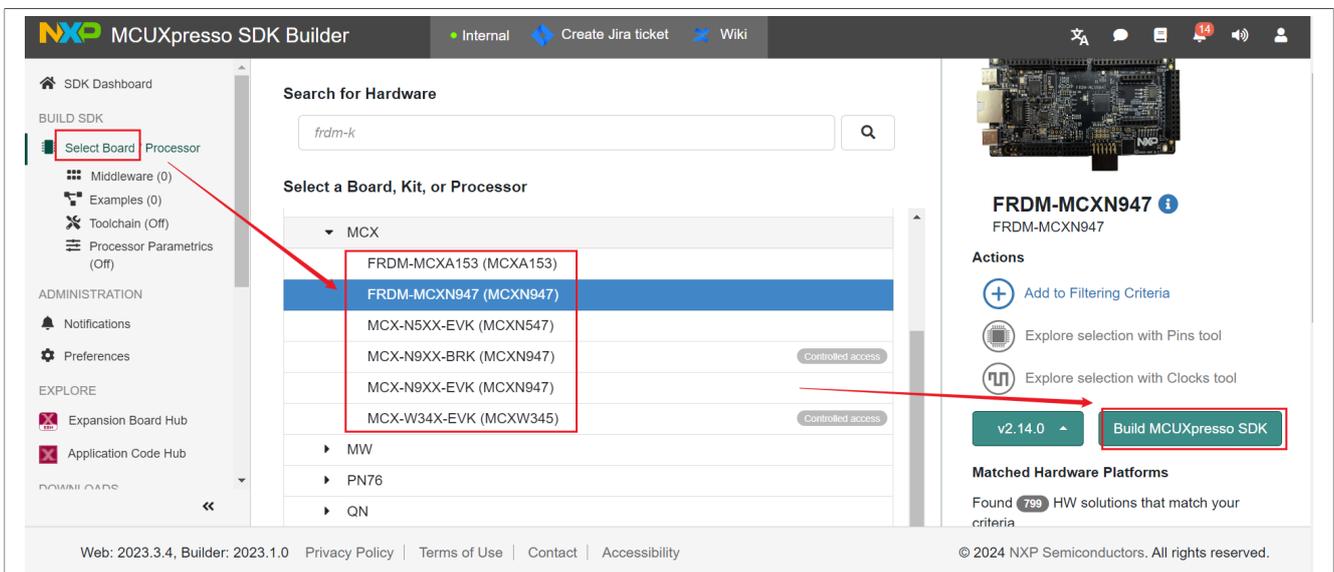


Figure 10. Build MCUxpresso SDK for selected board

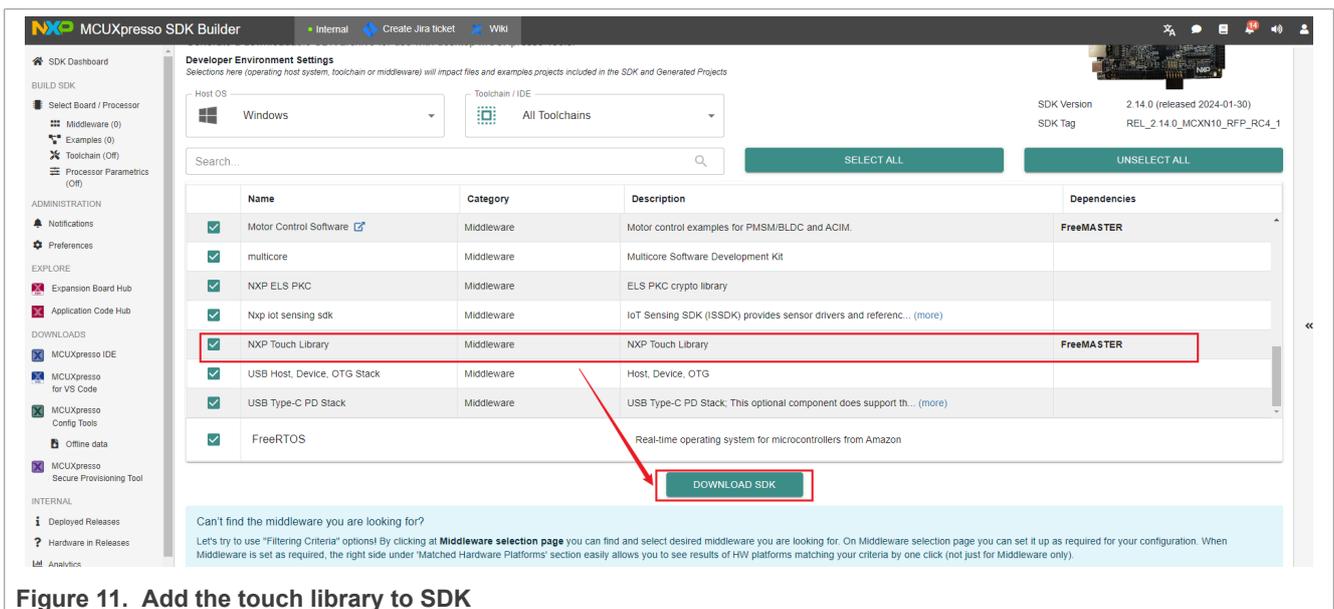


Figure 11. Add the touch library to SDK

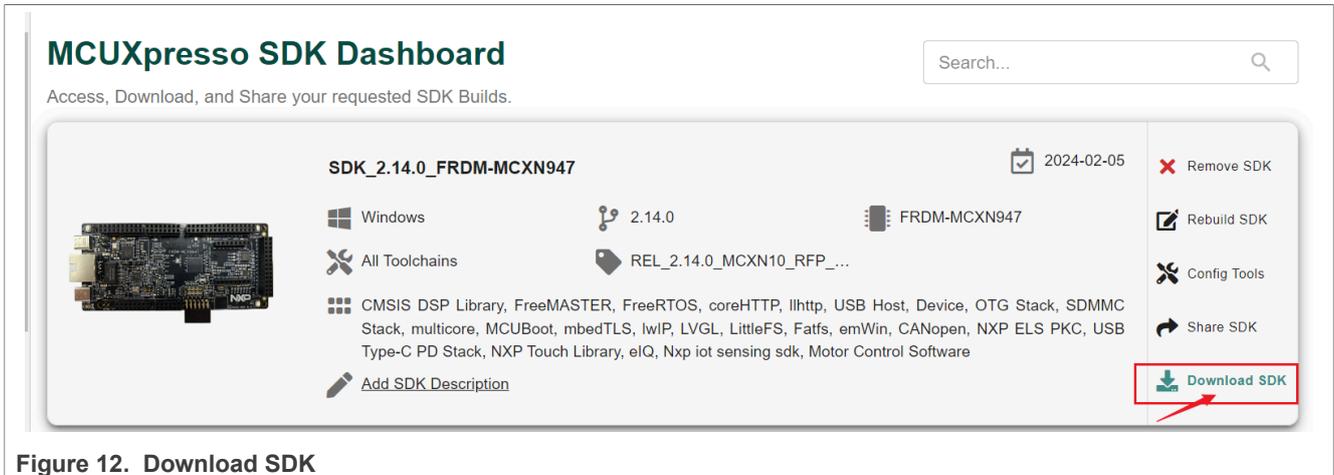


Figure 12. Download SDK

4.2.2 NXP touch library

The touch sensing code in the downloaded SDK folder `...\boards\frdmmcxcn947\demo_apps\touch_sensing` is developed using the NXP touch library.

The NXP Touch Library Reference Manual can be found in the folder `.../middleware/touch/freemaster/html/index.html`, it describes the NXP Touch software library for implementing touch-sensing applications on NXP MCU platforms. The NXP Touch software library provides touch-sensing algorithms to detect finger touch, movement, or gestures.

The FreeMASTER tool for TSI configure and tune is included into the NXP touch library. For more information, see the *NXP Touch Library Reference Manual* (document [NT20RM](#)) or *NXP Touch Development Guide* (document [AN12709](#)).

The basic building blocks of the NXP Touch library are shown in [Figure 13](#):

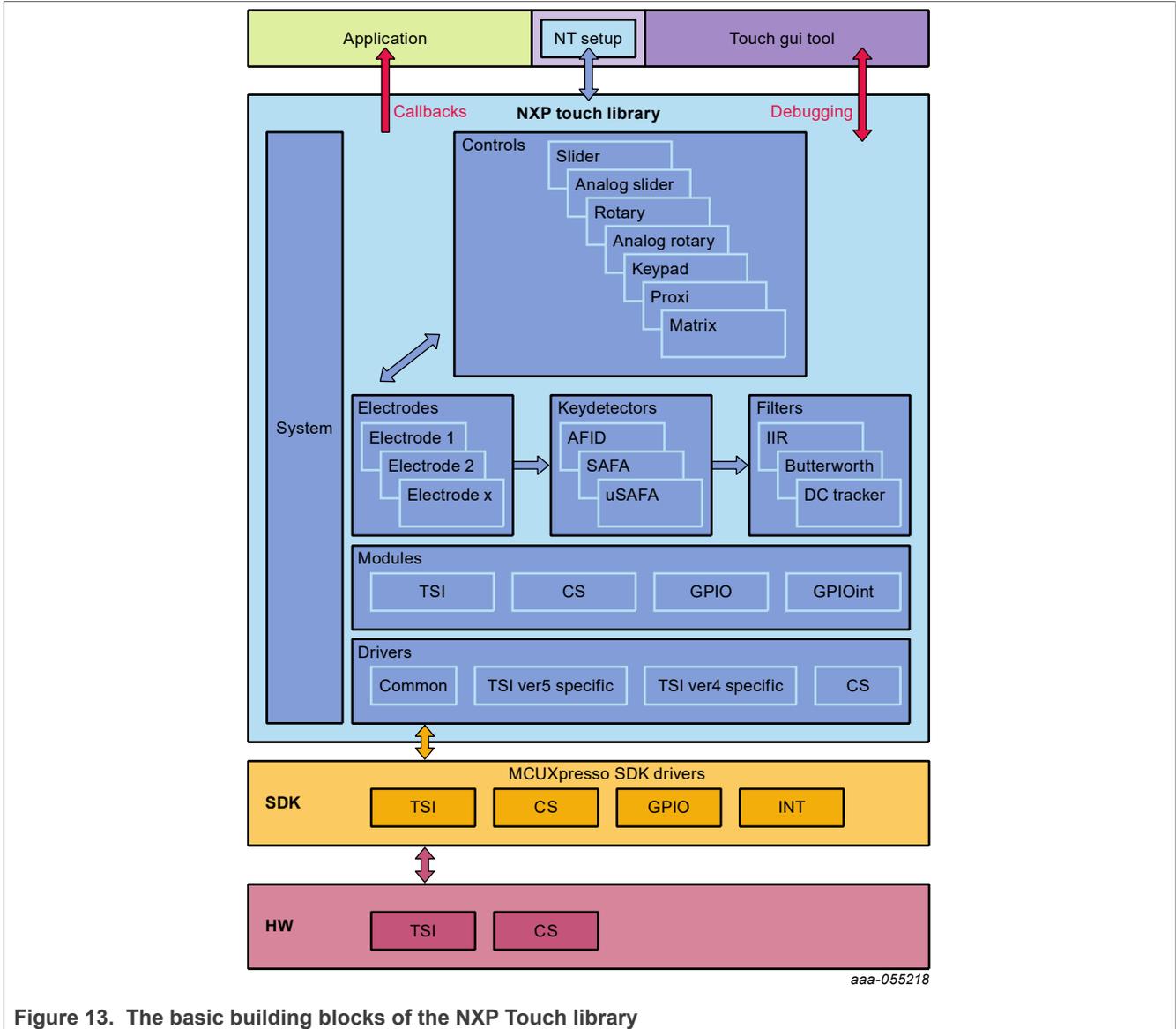


Figure 13. The basic building blocks of the NXP Touch library

5 MCX Nx4x TSI performance

For MCX Nx4x TSI, the following parameters have been tested on the X-MCX-N9XX-TSI board. Here is the performance summary.

Table 6. Performance summary

MCX Nx4x series		
1	SNR	Up to 200:1 for self-cap mode and mutual-cap mode
2	Overlay thickness	Up to 20 mm
3	Shield drive strength	Up to 600pF at 1MHz, Up to 200pF at 2MHz
4	Sensor capacitance range	5pF – 200pF

1. SNR test

The SNR is calculated according to the raw data of the TSI counter value. In the case when no algorithm is used to process the sampled values, SNR values of 200:1 can be achieved in self-cap mode and mutual-cap mode.

As shown in [Figure 14](#), the SNR test has been performed on the TSI board on EVB.

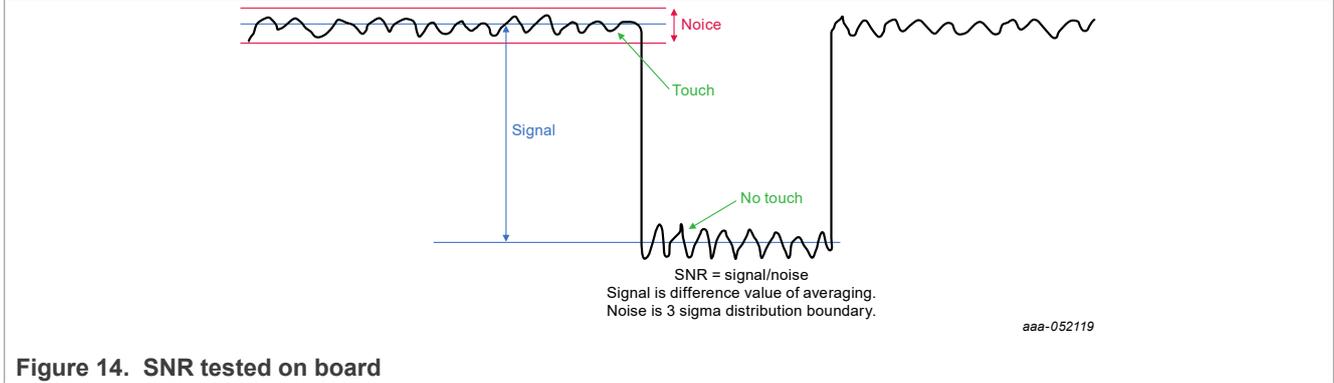


Figure 14. SNR tested on board

2. Shield drive strength test

The strong shield strength of TSI can improve the waterproof performance of the touchpad and can support a larger touchpad design on hardware board. When the 4 TSI shield channels are all enabled, the maximum driver capability of the shield channels is tested at 1 MHz and 2 MHz TSI working clocks in self-cap mode. The higher the TSI operating clock, the lower the drive strength of the shielded channel. If the TSI operating clock is lower than 1MHz, the maximum drive strength of the TSI is larger than 600 pF.

To do the hardware design, refer to the test results shown in [Table 7](#).

Table 7. Shield driver strength test result

Shield channel on	Clock	Max shield drive strength
CH0, CH6, CH12, CH18	1 MHz	600 pF
	2 MHz	200 pF

3. Overlay thickness test

To protect the touch electrode from the interference of the external environment, the overlay material must be closely attached to the surface of the touch electrode. There should be no air gap between the touch electrode and the overlay. An overlay with a high dielectric constant or an overlay with a small thickness improves the sensitivity of the touch electrode.

The maximum overlay thickness of the acrylic overlay material was tested on the X-MCX-N9XX-TSI board as shown in [Figure 15](#) and [Figure 16](#). The touch action can be detected on the 20 mm acrylic overlay. Here are the conditions to be fulfilled:

- SNR>5:1
- Self-cap mode
- 4 shield channels on
- The sensitivity boost

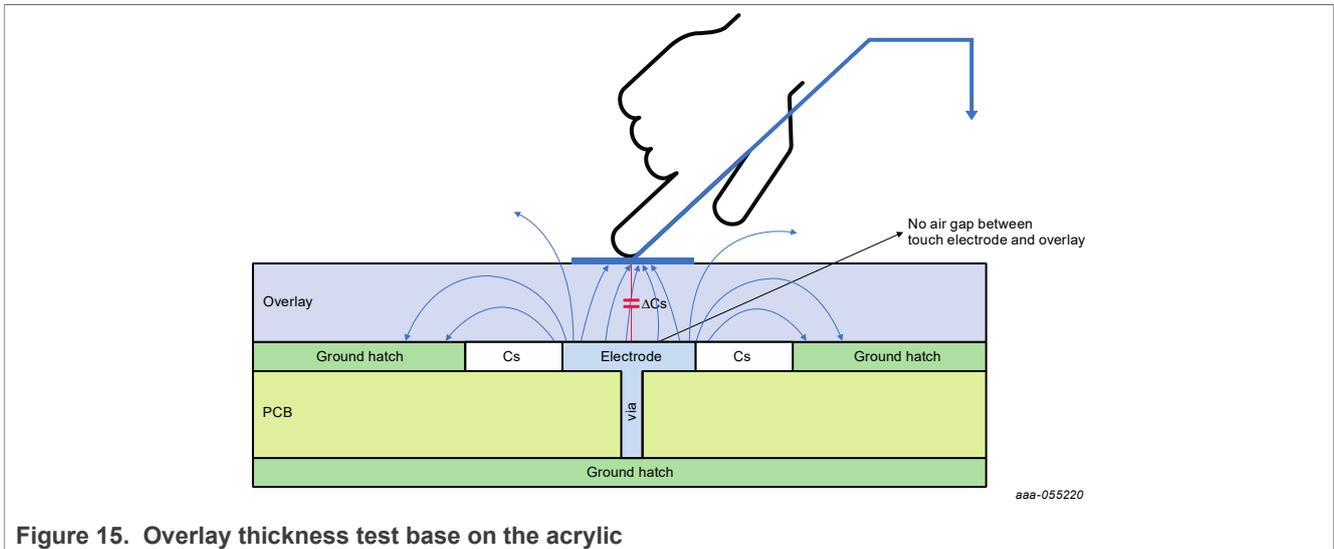


Figure 15. Overlay thickness test base on the acrylic

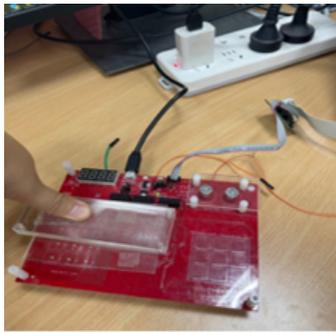


Figure 16. Overlay thickness test base on the acrylic

4. Sensor capacitance range test

The recommended intrinsic capacitance of a touch sensor on a hardware board is in the range of 5 pF to 50 pF. The area of the touch sensor, the material of the PCB, and the routing trace on the board affect the size of the intrinsic capacitance. These must be considered during the hardware design of the board. After testing on the X-MCX-N9XX-TSI board, MCX Nx4x TSI can detect a touch action when the intrinsic capacitance is as high as 200 pF, the SNR is larger than 5:1. Therefore, the requirements for touch board design are more flexible.

6 Conclusion

This document introduces the basic functions of TSI on MCX Nx4x chips. For details on the MCX Nx4x TSI principle, refer to the TSI chapter of the *MCX Nx4x Reference Manual* (document [MCXNx4xRM](#)). For suggestions of the hardware board design and touchpad design, refer to the *KE17Z Dual TSI User Guide* (document [KE17ZDTSIUG](#)).

7 References

The following references are available on NXP website:

1. *MCX Nx4x Reference Manual* (document [MCXNx4xRM](#))
2. *KE17Z Dual TSI User Guide* (document [KE17ZDTSIUG](#))

3. *NXP Touch development guide* (document [AN12709](#))

4. *NXP Touch Library Reference Manual* (document [NT20RM](#))

8 Revision history

Table 8. Revision history

Document ID	Release date	Description
UG10111 v.1	7 May 2024	Initial version

Legal information

Definitions

Draft — A draft status on a document indicates that the content is still under internal review and subject to formal approval, which may result in modifications or additions. NXP Semiconductors does not give any representations or warranties as to the accuracy or completeness of information included in a draft version of a document and shall have no liability for the consequences of use of such information.

Disclaimers

Limited warranty and liability — Information in this document is believed to be accurate and reliable. However, NXP Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information. NXP Semiconductors takes no responsibility for the content in this document if provided by an information source outside of NXP Semiconductors.

In no event shall NXP Semiconductors be liable for any indirect, incidental, punitive, special or consequential damages (including - without limitation - lost profits, lost savings, business interruption, costs related to the removal or replacement of any products or rework charges) whether or not such damages are based on tort (including negligence), warranty, breach of contract or any other legal theory.

Notwithstanding any damages that customer might incur for any reason whatsoever, NXP Semiconductors' aggregate and cumulative liability towards customer for the products described herein shall be limited in accordance with the Terms and conditions of commercial sale of NXP Semiconductors.

Right to make changes — NXP Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use — NXP Semiconductors products are not designed, authorized or warranted to be suitable for use in life support, life-critical or safety-critical systems or equipment, nor in applications where failure or malfunction of an NXP Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental damage. NXP Semiconductors and its suppliers accept no liability for inclusion and/or use of NXP Semiconductors products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk.

Applications — Applications that are described herein for any of these products are for illustrative purposes only. NXP Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

Customers are responsible for the design and operation of their applications and products using NXP Semiconductors products, and NXP Semiconductors accepts no liability for any assistance with applications or customer product design. It is customer's sole responsibility to determine whether the NXP Semiconductors product is suitable and fit for the customer's applications and products planned, as well as for the planned application and use of customer's third party customer(s). Customers should provide appropriate design and operating safeguards to minimize the risks associated with their applications and products.

NXP Semiconductors does not accept any liability related to any default, damage, costs or problem which is based on any weakness or default in the customer's applications or products, or the application or use by customer's third party customer(s). Customer is responsible for doing all necessary testing for the customer's applications and products using NXP Semiconductors products in order to avoid a default of the applications and the products or of the application or use by customer's third party customer(s). NXP does not accept any liability in this respect.

Terms and conditions of commercial sale — NXP Semiconductors products are sold subject to the general terms and conditions of commercial sale, as published at <https://www.nxp.com/profile/terms>, unless otherwise agreed in a valid written individual agreement. In case an individual agreement is concluded only the terms and conditions of the respective agreement shall apply. NXP Semiconductors hereby expressly objects to applying the customer's general terms and conditions with regard to the purchase of NXP Semiconductors products by customer.

Export control — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from competent authorities.

Suitability for use in non-automotive qualified products — Unless this document expressly states that this specific NXP Semiconductors product is automotive qualified, the product is not suitable for automotive use. It is neither qualified nor tested in accordance with automotive testing or application requirements. NXP Semiconductors accepts no liability for inclusion and/or use of non-automotive qualified products in automotive equipment or applications.

In the event that customer uses the product for design-in and use in automotive applications to automotive specifications and standards, customer (a) shall use the product without NXP Semiconductors' warranty of the product for such automotive applications, use and specifications, and (b) whenever customer uses the product for automotive applications beyond NXP Semiconductors' specifications such use shall be solely at customer's own risk, and (c) customer fully indemnifies NXP Semiconductors for any liability, damages or failed product claims resulting from customer design and use of the product for automotive applications beyond NXP Semiconductors' standard warranty and NXP Semiconductors' product specifications.

Translations — A non-English (translated) version of a document, including the legal information in that document, is for reference only. The English version shall prevail in case of any discrepancy between the translated and English versions.

Security — Customer understands that all NXP products may be subject to unidentified vulnerabilities or may support established security standards or specifications with known limitations. Customer is responsible for the design and operation of its applications and products throughout their lifecycles to reduce the effect of these vulnerabilities on customer's applications and products. Customer's responsibility also extends to other open and/or proprietary technologies supported by NXP products for use in customer's applications. NXP accepts no liability for any vulnerability. Customer should regularly check security updates from NXP and follow up appropriately. Customer shall select products with security features that best meet rules, regulations, and standards of the intended application and make the ultimate design decisions regarding its products and is solely responsible for compliance with all legal, regulatory, and security related requirements concerning its products, regardless of any information or support that may be provided by NXP.

NXP has a Product Security Incident Response Team (PSIRT) (reachable at PSIRT@nxp.com) that manages the investigation, reporting, and solution release to security vulnerabilities of NXP products.

NXP B.V. — NXP B.V. is not an operating company and it does not distribute or sell products.

Trademarks

Notice: All referenced brands, product names, service names, and trademarks are the property of their respective owners.

NXP — wordmark and logo are trademarks of NXP B.V.

AMBA, Arm, Arm7, Arm7TDMI, Arm9, Arm11, Artisan, big.LITTLE, Cordio, CoreLink, CoreSight, Cortex, DesignStart, DynamIQ, Jazelle, Keil, Mali, Mbed, Mbed Enabled, NEON, POP, RealView, SecurCore, Socrates, Thumb, TrustZone, ULINK, ULINK2, ULINK-ME, ULINK-PLUS, ULINKpro, μ Vision, Versatile — are trademarks and/or registered trademarks of Arm Limited (or its subsidiaries or affiliates) in the US and/or elsewhere. The related technology may be protected by any or all of patents, copyrights, designs and trade secrets. All rights reserved.

Kinetis — is a trademark of NXP B.V.

MCX — is a trademark of NXP B.V.

Microsoft, Azure, and ThreadX — are trademarks of the Microsoft group of companies.

Contents

1	Introduction	2
2	MCX Nx4x TSI overview	2
2.1	MCX Nx4x TSI block diagram	2
2.2	MCX Nx4x parts supported TSI	3
2.3	MCX Nx4x TSI channel assignment on different packages	3
3	MCX Nx4x TSI features	5
3.1	TSI comparison between MCX Nx4x TSI and Kinetis TSI	5
3.2	MCX Nx4x TSI new features	6
3.3	MCX Nx4x TSI function description	7
3.4	Example use case of MCX Nx4x TSI new function	9
4	MCX Nx4x TSI hardware and software support	9
4.1	MCX Nx4x series TSI evaluation board	9
4.1.1	X-MCX-N9XX-TSI board	9
4.1.2	MCX-N5XX-EVK	10
4.1.3	MCX-N9XX-EVK	10
4.1.4	FRDM-MCXN947	11
4.2	NXP touch library support for MCX Nx4x TSI	12
4.2.1	SDK build and touch library download	12
4.2.2	NXP touch library	13
5	MCX Nx4x TSI performance	14
6	Conclusion	16
7	References	16
8	Revision history	17
	Legal information	18

Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.
